

Amendments to the Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application.

Listing of Claims:

Claim 1. (currently amended): An ~~analyser~~ analyzer or spectrophotometer for the detection of material in a sample comprising:

a source of radiation adapted to direct said radiation at least at said sample, the frequency of said radiation incident on or ~~reflected~~ affected by said sample able to be varied by varying the intensity of the said source radiation;

a detector for detecting at least radiation ~~reflected~~ affected by said sample, ~~wherein~~ said detector having a spectral response able to be varied and an output depending on radiation incident thereon and said spectral response;

a controller or processor receiving said output, configured or programmed to:
vary the intensity of said source radiation to produce source radiation with a range of frequencies;

vary the spectral response of said detector to produce a plurality of detector response frequency bands, wherein each detector response frequency band is tuned to an associated range of frequencies of the source radiation;

for each detector response frequency band, obtain output from the detector resulting from detection of one or more frequencies of incident source radiation affected by the sample when the source radiation is varied to contain the range of frequencies associated with the detector response frequency band; and

determine a characteristic of said sample based on said output obtained for each detector response frequency band when said detector has detected the reflection from a sample of an associated frequency or range of frequencies of incident source radiation ~~in relation to said variations.~~

Claim 2. (canceled)

Claim 3. (currently amended): A method of detecting material in a sample comprising the steps of

- directing radiation at said sample,
- varying the intensity of said radiation incident on or ~~reflected~~ affected by said sample to produce source radiation with a range of frequencies,
- detecting at least radiation ~~reflected~~ affected by said sample using a detector,
- ~~providing a variable~~ varying the spectral response of said detector to produce a plurality of detector response frequency bands wherein each detector response frequency band is tuned to an associated range of frequencies of the varied source radiation,
- for each detector response frequency band, obtaining output from the detector resulting from detection of one or more frequencies of incident source radiation affected by said sample when the source radiation is varied to contain the range of frequencies associated with the detector response frequency band, and
- ~~providing a variable spectral response output representative of said detected radiation, and~~
- determining a characteristic of said sample based on output obtained for each detector response frequency band when said detector has detected the reflection from a sample of an associated frequency or range of frequencies of incident source radiation ~~said output in relation to said variations.~~

Claim 4. (currently amended): An ~~analyser~~, analyzer or spectrophotometer ~~or method~~ as claimed in claim 1 wherein the intensity of said source radiation directed at said sample is varied by varying the voltage or current supplied to the radiation source.

Claim 5. (currently amended): An ~~analyser~~, analyzer or spectrophotometer ~~or method~~ as claimed in claim 1 wherein the intensity of said source radiation directed at said sample is varied by varying the transmission path between the radiation source and said sample.

Claims 6 - 8. (canceled)

Claim 9. (currently amended): An ~~analyser~~, analyzer or spectrophotometer or method as claimed in claim 1 wherein the radiation ~~reflected~~ affected by said sample is detected by a photodiode and the spectral response of said output is varied by varying the width of the depletion zone within said diode.

Claim 10. (currently amended): An ~~analyser~~, analyzer or spectrophotometer or method as claimed in claim 9 wherein the width of the depletion zone within said diode is varied by varying the reverse voltage applied across the diode and the output being the resulting current.

Claim 11. (currently amended): An ~~analyser~~, analyzer or spectrophotometer or method as claimed in claim 1 ~~2~~ wherein said output signal from said detector is amplified and ~~digitised~~ digitized prior to being supplied to said controller.

Claim 12. (currently amended): An ~~analyser~~, analyzer or spectrophotometer or method as claimed in claim 11 wherein said controller is a microprocessor.

Claim 13. (currently amended): An ~~analyser~~, analyzer or spectrophotometer or method as claimed in claim 11 wherein said detector is a photodiode detector.

Claim 14. (currently amended): An ~~analyser~~, analyzer or spectrophotometer or method as claimed in claim 11 wherein said source is a light emitting diode.

Claim 15. (currently amended): An ~~analyser~~, analyzer or spectrophotometer or method as claimed in claim 11 wherein said source is a tungsten filament lamp.

Claim 16. (currently amended): An ~~analyser~~, analyzer or spectrophotometer or method as claimed in claim 11 wherein said source is a gas discharge lamp.

Claim 17. (currently amended): An ~~analyser~~ analyzer or spectrophotometer for the detection of material in a sample according to claim 1 further comprising:

~~a source adapted to direct radiation at least at said sample,~~
~~a detector configured to provide an output indicative of at least radiation reflected~~
~~by said sample,~~

a variable transmission path for directing radiation in a first configuration
between said source~~[[,]]~~ and said sample or in a second configuration between said source and
said detector, ~~configured to vary at least intensity of radiation incident on said sample, and~~
wherein, [[a]] the controller or processor receiving said output and operating is further
configured or programmed to:

control said variable transmission path, configured or programmed to between
first and second configurations,

determine the radiation ~~reflected from said source off~~ affected by said sample
using said output of said detector,

determine the radiation directly from said source using said output of said
detector, and

determine a characteristic of said sample based on said output of said detector in
relation to variations in said transmission path.

Claims 18 - 19. (canceled)

Claim 20. (currently amended): An ~~analyser, analyzer or spectrophotometer or~~
~~method~~ as claimed in claim 17 wherein when said variable transmission path is in the first
configuration, radiation passes to said sampling along reflects off said sample along a sample
path and when the variable transmission path is in the second configuration radiation passes
directly to ~~[[the]]~~ said detector along a reference path.

Claim 21. (currently amended): An ~~analyser, analyzer or spectrophotometer or~~
~~method~~ as claimed in claim 20 wherein [[a]] said variable transmission path is controlled
between said first and second configurations using a blocking member having at least 3 cyclic
modes comprising:

a first mode during which said blocking member is operated to control the

variable transmission path into said second configuration where said radiation passes along said reference path,

a second mode during which said blocking member is operated to control said variable transmission path into said first configuration where said radiation passes along said sample path, and

a third mode during which said radiation is blocked.

Claim 22. (currently amended): An ~~analyser~~, analyzer or spectrophotometer or ~~method~~ as claimed in claim 21 wherein said blocking member is rotatable about a central axis.

Claim 23. (currently amended): An ~~analyser~~, analyzer or spectrophotometer or ~~method~~ as claimed in claim 22 wherein during said first mode the intensity of said radiation through said sample path is varied.

Claim 24. (currently amended): An ~~analyser~~, analyzer or spectrophotometer or ~~method~~ as claimed in claim 23 wherein the intensity is varied by providing different sized apertures in an annular path through said blocking member.

Claim 25. (currently amended): An ~~analyser~~, analyzer or spectrophotometer or ~~method~~ as claimed in claim 24 wherein said blocking member includes indexing and a sensor(s) to detect the position of said blocking member.

Claims 26 - 28. (canceled)

Claim 29. (new): An analyzer or spectrophotometer as claimed in claim 1 wherein the intensity of the source radiation is varied by switching the source on, the transition from the off state to the on state resulting in a range of source radiation intensities that produces source radiation at a range of frequencies.

Claim 30. (new): A method as claimed in claim 3 wherein the intensity of the source radiation is varied by switching the source on, the transition from the off state to the on

state resulting in a range of source radiation intensities that produces source radiation at a range of frequencies.

Claim 31. (new): A method as claimed in claim 3 wherein the intensity of the source radiation directed at said sample is varied by varying the voltage or current supplied to the radiation source.

Claim 32. (new): A method as claimed in claim 3 wherein the intensity of said source radiation directed at said sample is varied by varying the transmission path between the radiation source and said sample.

Claim 33. (new): A method as claimed in claim 3 wherein the radiation affected by said sample is detected by a photodiode and the spectral response of said detector is varied by varying the width of the depletion zone within said diode.

Claim 34. (new): A method as claimed in claim 33 wherein the width of the depletion zone within said diode is varied by varying the reverse voltage applied across the diode and the output being the resulting current.

Claim 35. (new): A method as claimed in claim 3 wherein said output from said detector is amplified and digitized prior to being supplied to said controller.

Claim 36. (new): A method according to claim 3 wherein the radiation transmission path is varied to direct radiation between said source and said sample in the first configuration or between said source and said detector in the second configuration, wherein the controller or processor is further configured or programmed to:

- control a variable transmission path in said first configuration,
- control a variable transmission path in said second configuration,
- determine the output of the said detector in said first configuration,
- determine the output of the said detector in said second configuration, and

determine a characteristic of said sample based on the difference of said outputs of said detector.

Claim 37. (new): A method as claimed in claim 36 wherein when said variable transmission path is in the first configuration, radiation passes to said sample along a sample path and when the variable transmission path is in the second configuration, radiation passes directly to said detector along a reference path.

Claim 38. (new): A method as claimed in claim 37 wherein said variable transmission path is controlled between said first and second configurations by controlling a blocking member into one of at least 3 cyclic modes comprising:

a first mode during which said blocking member is operated to control said variable transmission path into said first configuration where said radiation passes along said sample path,

a second mode during which said blocking member is operated to control the variable transmission path into said second configuration where said radiation passes along said reference path, and

a third mode during which said radiation is blocked.

Claim 39. (new): A method as claimed in claim 38 wherein said blocking member is controlled into one of the modes by rotating the blocking member about a central axis.

Claim 40. (new): A method as claimed in claim 39 further comprising varying the intensity of said radiation through said sample path during the first mode.

Claim 41. (new): A method as claimed in claim 40 comprising varying the intensity by providing different sized apertures in an annular path through said blocking member.